 ch Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/716,364	MEHAN ET AL.
Examiner	Art Unit
Sam Chuan C. Yao	1733

	SEARCHED				
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			-	
	e search via ST	10/18/2006	SCY	

DATE 10/18/2006	SCY
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